

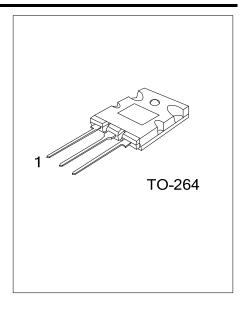
# UNISONIC TECHNOLOGIES CO., LTD

75NM70 **Preliminary Power MOSFET** 

# **75A, 700V N-CHANNEL** SUPER-JUNCTION MOSFET

#### DESCRIPTION

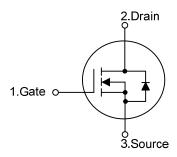
The UTC 75NM70 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.



#### **FEATURES**

- \*  $R_{DS(ON)}$  < 70m $\Omega$  @  $V_{GS}$  = 10V,  $I_{D}$  = 37.5A
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

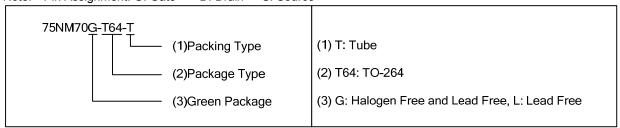
#### **SYMBOL**



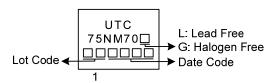
# **ORDERING INFORMATION**

Ordering Number		Doolsono	Pin Assignment			Deaking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
75NM70L-T64-T	75NM70G-T64-T	TO-264	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



#### **MARKING**



www.unisonic.com.tw 1 of 5

# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	700	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Continuous	I <sub>D</sub>	75	Α	
	Pulsed (Note 2)	I <sub>DM</sub>	150	Α	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	922	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	15	V/ns	
Power Dissipation		$P_D$	255	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature Range		T <sub>STG</sub>	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=5mH,  $I_{AS}$ =19.2A,  $V_{DD}$ =50V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C.
- 4.  $I_{SD} \le 30A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J = 25$ °C.

## ■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	$\theta_{JA}$	40	°C/W	
Junction to Case	$\theta_{JC}$	0.4	°C/W	

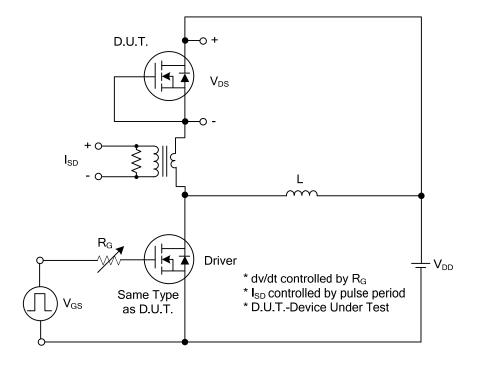
# ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C, unless otherwise specified)

1		†						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}$ =0V, $I_D$ =250 $\mu$ A	700			V		
Drain-Source Leakage Current	$I_{DSS}$	V <sub>DS</sub> =700V, V <sub>GS</sub> =0V			10	μΑ		
Gate-Source Leakage Current	$I_{GSS}$	$V_{DS}$ =0V , $V_{GS}$ =±30V			±100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			4.5	V		
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS} = 10V, I_D = 37.5A$			70	mΩ		
DYNAMIC PARAMETERS								
Input Capacitance	C <sub>ISS</sub>			5000		pF		
Output Capacitance	Coss	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1.0MHz		2500		pF		
Reverse Transfer Capacitance	$C_{RSS}$			7		pF		
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)	$Q_G$	V 000V V 75V		205		nC		
Gate to Source Charge	$Q_GS$	V <sub>DS</sub> =300V, V <sub>GS</sub> =75V, I <sub>D</sub> =1.3A , I <sub>G</sub> =1mA (Note 1, 2)		48		nC		
Gate to Drain Charge	$Q_GD$	TID=1.3A , IG=1IIIA (Note 1, 2)		88		nC		
Turn-ON Delay Time (Note 1)	$t_{D(ON)}$			96		ns		
Rise Time	$t_R$	V <sub>DD</sub> =300V, V <sub>GS</sub> =10V,		62		ns		
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	$I_D$ =30A, $R_G$ =25 $\Omega$ (Note 1, 2)		680		ns		
Fall-Time	$t_{F}$			220		ns		
SOURCE- DRAIN DIODE RATINGS AND CHA	ARACTERIS <sup>®</sup>	TICS						
Maximum Body-Diode Continuous Current	Is				75	Α		
Maximum Body-Diode Pulsed Current	I <sub>SM</sub>				150	Α		
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	I <sub>S</sub> =75A, V <sub>GS</sub> =0V			1.4	V		
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =30A, V <sub>GS</sub> =0V,		770		ns		
Body Diode Reverse Recovery Charge	$Q_{rr}$	dI <sub>F</sub> /dt=100A/μs		18		μC		
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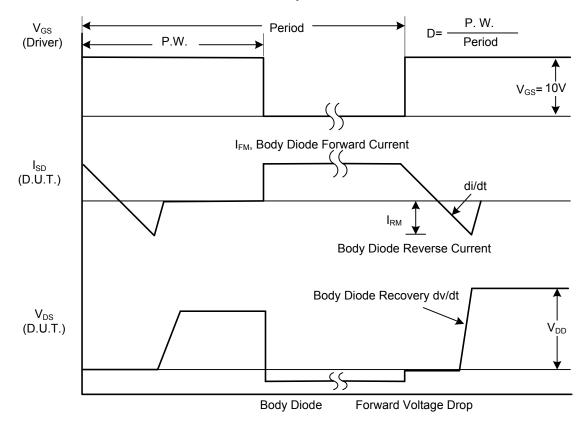
Notes: 1. Pulse Test : Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2%.

2. Essentially independent of operating temperature.

## **■ TEST CIRCUITS AND WAVEFORMS**

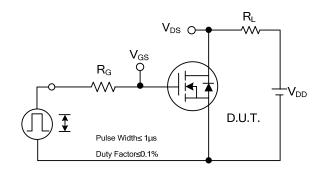


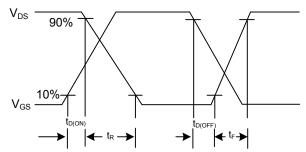
# Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

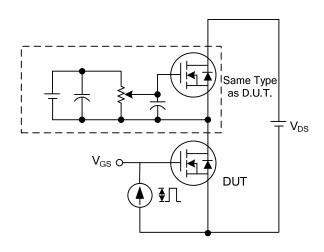
# ■ TEST CIRCUITS AND WAVEFORMS (Cont.)

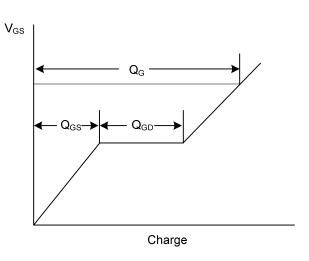




**Switching Test Circuit** 

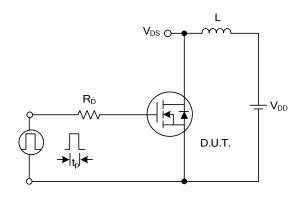
**Switching Waveforms** 

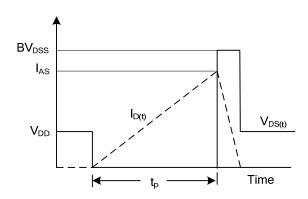




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

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